

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/663,742	HAMAMURA ET AL.		
Examiner	Art Unit		
Michelle K. Lay	2628		

	SEARCHED				
Class	Subclass	Date	Examiner		
348	51 42	5/8/2006	MKL		
345	633	5/8/2006	MKL		
715	838	5/8/2006	MKL		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
348	51	5/8/2006	MKL		
345	633	5/8/2006	MKL		
715	838	5/8/2006	MKL		
Interferen	Interference search		MKL		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search	5/8/2006	MKL		
Interference search	5/8/2006	MKL		